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Ab initio calculation of electronic properties of $Ga_{1-x}Al_xN$ alloys

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Abstract. The electronic properties of the wide-band-gap semiconducting ordered $Ga_{1-x}Al_xN$ alloys (for x = 0.0, 0.25, 0.50, 0.75 and 1.0) and the random alloys have been investigated by using a full-potential self-consistent linear muffin tin orbital (LMTO) method. The calculated direct band gap for random distribution of cation nearest-neighbour tetrahedral clusters in the $Ga_{1-x}Al_xN$ alloys for any arbitrary concentration x is seen to show a quite linear variation in agreement with the experiment. On the other hand, the indirect band gap remains invariant. We observe a direct to indirect band gap crossover at x = 0.59. The band gap bowing is seen to be very small.

1. Introduction

There has been tremendous interest in the development of optoelectronic devices, especially for obtaining light emitting diodes and laser emitting devices in the ultraviolet region (Lei and Moustakas 1992, Van der Walle 1993, Wettling and Windschif 1984, Xia *et al* 1993). This has led to a search for wide-band-gap semiconductors possessing band gaps of more than 2.0 eV. One type of candidate is GaN, AlN, and their alloys, opening a possibility of varying the band gap from 3.4 eV in GaN to 6.2 eV in AlN. The emitted short-wavelength electromagnetic radiation will lie up to the ultraviolet region.

The development of the epitaxial growth technique has made possible the preparation of semiconductor grade films of $Ga_{1-x}Al_xN$ alloys (*x* is the fractional concentration of Al atoms). Intrinsic carrier concentrations in the range $10^{16}-10^{17}$ cm⁻³ and mobilities up to 600 cm² V⁻¹ s⁻¹ have been measured (Amano *et al* 1989). Controlled p-type (with Mg) and n-type (with Si) doping has been achieved (Akasaki and Amano 1992, Molnar and Moustakas 1993, Nakamura *et al* 1991). Akasaki and Amano (1992) have demonstrated the fabrication of the light emitting diodes in the ultraviolet region from $Ga_{1-x}Al_xN/GaN$ heterostructures and also stimulated emission.

In their natural form, both GaN and AlN possess the hexagonal wurtzite structure. However, it has been possible to have a stabilized zinc-blende structure of GaN on GaAs(001) substrates (Martin *et al* 1991, Mizuta *et al* 1986, Ueno *et al* 1994, Miwa and Fukumotoa 1993, Strike *et al* 1991) and also on cubic SiC(001) substrates (Paisley *et al* 1989, 1992, Gorczyka and Christensen 1991, Perlin *et al* 1992a, b, Schrwin and Drummond 1991). Also, there is evidence of the zinc-blende AlN in the form of precipitates (Lei *et al* 1992). It has been seen that the energy difference between the wurtzite and zinc-blende structures of GaN and AlN per unit cell is quite small, of the order of 20–30 meV for GaN (Muñoz and Kunc 1991, Yeh *et al* 1992) and 36 meV for AlN (Lambrecht and Segall 1992).

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On the theoretical side, only a very few first-principles calculations have been performed to elucidate the physical properties of $Ga_{1-x}Al_xN$ alloys. Albanesi *et al* (1993) have performed an LMTO calculation in the atomic sphere approximation (ASA) and have shown a weak bowing in the variation of the energy gap.

Usually in the application of the standard LMTO method, an atomic sphere approximation (ASA) is used to make it efficient. However, this LMTO–ASA method suffers from several disadvantages. (i) It neglects the symmetry breaking terms by discarding the nonspherical parts of the electron density. (ii) The method discards the interstitial region by replacing the muffin tin spheres by space filling Wigner spheres. (iii) It uses spherical Hankel functions with vanishing kinetic energy only.

The present LMTO method (Methfessel 1988) goes beyond the LMTO method usually employed in the ASA.

2. Theory

2.1. The LMTO method

It has been noted that quite reliable results can be attained by employing an LMTO basis set if all the potential terms are determined accurately. For this, the sizes of the atomic spheres are shrunk so as to make them nonoverlapping. The potential matrix elements are then split into two parts, one contribution from the atomic spheres and the other from the complicated interstitial region. The first part, i.e. the atomic sphere one, is easy to evaluate by expanding it in terms of the usual spherical harmonics. On the other hand, the evaluation of the interstitial contribution is quite difficult and very time consuming if done by standard techniques. Efforts have been made to find an efficient and quick way to determine the interstitial contribution. In the method used in the present work, the interstitial quantities were expanded in terms of the spherical Hankel functions. The threecentre integrals involved were expressed as linear combinations of the two-centre integrals by numerical means. These two-centre integrals, involving Hankel functions, can easily be evaluated analytically. The method is applicable to the periodic as well as the nonperiodic systems which so often need to be treated especially when impurities, defects and lattice distortions or atomic relaxations occur.

2.2. Statistical properties of disordered alloys

The statistical mechanical properties of the disordered alloys can be obtained by using the cluster expansion method (Sanchez and de Fontaine 1981, Sanchez *et al* 1984, Srivastava *et al* 1985) and the idea of Connolly and Williams (1983) who suggested that the coefficients of the cluster expansion may be derived by a first-principles calculations of a set of ordered compounds. The method which was primarily used for the binary alloys may easily be applied to the ternary alloys if one assumes that the disorder occurs only on one type of site, say cation, as is the case for the $Ga_{1-x}Al_xN$ alloys (*x* denotes the fractional concentration). The problem further simplifies if one truncates the cluster expansion at the level of the nearest-neighbour tetrahedron interactions. One may consider the five basic types of cation nearest-neighbour tetrahedron $A_{4-n}B_n$ with the values of the integer n = 0-4. Let $P_n(x)$ be the probability of the occurrence of the cation tetrahedrons $A_{4-n}B_n$ in the disordered alloy of concentration *x*. Then, a property *F* may be expanded as

$$F(x) = \sum_{n} P_n(x) F_n \tag{1}$$

where F_n is the property for the cation tetrahedron $A_{4-n}B_n$.

In the cluster expansion method, one has to determine the probability of each cluster $P_n(x, T)$ at a given temperature T by minimizing the free energy with respect to $P_n(x, T)$. We assume (similar to others, e.g. Srivastava *et al* 1985, Albanesi *et al* 1993) a temperature independent random distribution function,

$$P_n(x) = \binom{4}{n} x^n (1-x)^{4-n}.$$
 (2)

Obviously, this is a first approximation but it may be valid for the case of frozen-in disorder of the gas or liquid phase from which the solid solutions are quenched.

In the present study, we have not relaxed the bond lengths as has been studied by Srivastava *et al*, who have pointed out that positive optical bowing may result by local bond relaxation effects.

In the present investigations, the full-potential LMTO method has been used to study the electronic properties of GaN, AlN and their ordered and random alloys $Ga_{1-x}Al_xN$. The calculated results of the electronic structure, total density of states and the electronic charge densities for the GaN, AlN and $Ga_{1-x}Al_xN$ systems using an eight-atom supercell are presented in section 3. Section 4 includes the main conclusions.



Figure 1. The dispersion curves for a Ga₄N₄ supercell containing an eight-atom unit cell.



Figure 2. The dispersion curves for GaN containing a two-atom unit cell.

3. Calculation and results

We employ a unit cell containing four molecular units, i.e. $Ga_{4-n}Al_nN_4$ for n = 0-4. In order to reproduce the usual zinc-blende structure for this quadrupole unit cell, one has to use a different lattice, namely the simple cubic (sc) one with the translation vector of length *a*. As has also been pointed out by Srivastava *et al*, various crystal structure choices for n = 1, 2, 3 are possible.

In the present method (Methfessel 1988, Agrawal et al 1994a, Agrawal and Agrawal 1994a, b, 1995), we expand the multiple products of the LMTO envelopes required for the charge density and the potential in terms of the Hankel functions with the spherical harmonic components $1 \leqslant 4$ and of the kinetic energies -0.01, -1.0, and -2.3 Ryd with the two different types of decay specified by $\lambda^2 = -1$ and 3 Ryd. The supercell contains eight real and eight empty spheres. All the calculations have been performed considering the scalar relativistic effects. The Hedin-Lundquist (1971) parametrization of the exchange-correlation potential was employed in the calculations. The core electrons are allowed to relax and the core electron charge density is recalculated in each iteration of the self-consistent calculation. The value of the calculated fundamental energy gap in the local density approximation is usually seen to be smaller than the experimental value. This is understood to originate from the fact that the eigenvalues of the Kohn-Sham equation (Perdew and Levy 1983, Sham and Schluter 1983) are not excitation energies of the systems. Good estimates of the energy gap may be obtained by solving the quasi-particle equations (Goodby et al 1986) when the exchange and correlation effects are described by the selfenergy. This self-energy is a nonlocal energy-dependent effective potential. However, this



Figure 3. The total electronic density of states for random $Ga_{1-x}Al_xN$ alloys for (a) x = 0.0, (b) x = 0.25, (c) x = 0.50, (d) x = 0.75 and (e) x = 1.0.

is beyond the scope of the present work.

As noted above, the lattice is sc for the quadrupole unit cell used, which, in turn, leads to an sc Brillouin zone. Also, the electronic structure corresponding to the quadrupole unit cell will exhibit folding of the dispersion curves which will be discussed in detail a little later.

The radii of the nonoverlapping spheres around each atom were varied to see the variation in the values of the lattice parameters. The variation was made from that of equal radii for both cation and anion to unequal radii proportional to the atomic radii of the atoms. The values of determined equilibrium lattice parameters change within 1-2%.

The calculated lattice parameters for the minimum lattice energy volumes are compared with the other calculations and the available experimental data for the ordered $Ga_{1-x}Al_xN$ structures in table 1. The variation in the lattice parameter is seen to be linear. Our values



Figure 4. The dispersion curves for the ordered Ga₃AlN₄ structure.

are quite similar to those obtained by Albanesi *et al* (1993) and are in excellent agreement with the experiment for the end alloys. Our values are slightly on the higher side. We now discuss each alloy separately.

Table 1. Calculated lattice constants (in ångströms) for the ordered $Ga_{1-x}Al_xN$ structures.

Systems	Present work	Other calculation	Experiment
GaN	4.510 ± 0.010	4.48 ^a , 4.42 ^b , 4.30 ^c	4.50 ^d
Ga _{0.75} Al _{0.25} N	4.485 ± 0.005	4.46 ^a	
Ga _{0.50} Al _{0.50} N	4.450 ± 0.010	4.43 ^a	
Ga _{0.25} Al _{0.75} N	4.415 ± 0.015	4.39 ^a	
AlN	4.370 ± 0.020	4.35 ^{a,b}	4.37 ^d

^a LMTO–ASA (Albanesi et al 1993).

^b Pseudo-potential (Rubio et al 1993, 1995).

^c Pseudo-potential (Jenkins et al 1994).

^d Wyckoff (1964).

3.1. GaN

The radius of the non-overlapping spheres drawn around each real and empty atom was chosen as 1.815 au. Ga (4s, 4p, 3d) and N (2s, 2p) states are considered as the valence states. The point group symmetry at each site is T_d . The calculations were performed for



Figure 5. The dispersion curves for the ordered Ga₂Al₂N₄ structure.

28 selected k-points in the irreducible part of the Brillouin zone to achieve self-consistency in the charge density.

The electronic dispersion curves for GaN are presented in figure 1. In order to facilitate comparison, we present here the electronic structure for the simplest two-atom unit cell of GaN having a zinc-blende structure in figure 2. One observes a direct band gap. The comparatively flat 3d states of Ga appear just near the bottom of the valence band and they hybridize strongly with the 2s states of N.

The symmetry points for the sc Brillouin zone for the super unit cell as shown in figure 1 are $\Gamma(0, 0, 0)$, X(1, 0, 0), M(1, 1, 0), R(1, 1, 1) and Z(1, 0.5, 0). The nomenclature of symmetry points except the Γ and X points is different from those of the symmetry points of the bcc Brillouin zone of the zinc-blende structure. As pointed out earlier, the electronic structure of the eight-atom unit cell shows zone folding. Thus, at the Γ -point, the state appearing at the conduction band minimum of the sc Brillouin zone. At the Γ -point, along with the triplet value valence states Γ_{15v}^{sc} at the top of the valence band and the singlet conduction Γ_{1c}^{sc} state lying at the bottom of the X point of the zinc-blende structure. The direct band gap of 1.9 eV appearing in the two-atom unit cell remains a direct one in the Ga₄N₄ unit cell. However, the same is not true for the systems showing indirect band gaps for large concentrations of Al atoms as seen later.

The electron density of states has been obtained by employing 110 selected k points in the irreducible part of the Brillouin zone with a Gaussian broadening of 0.005 Ryd. The



Figure 6. The dispersion curves for the ordered GaAl₃N₄ structure.

result for the total density of states for the Ga_4N_4 ordered structure is shown in figure 3(a).

The bottom of the valence band extends up to -16.0 eV and is comprised of mainly the Ga 3d states slightly mixed with the N 2s sates. The main peaks in this region appear near -14.8, -13.3, and -11.3 eV. The states near the top of the valence band arise mainly from the hybridized N 2p and Ga 4p-like orbitals and they extend up to 7.5 eV towards the low-energy side.

The density functional theory–local density approximation gap is always smaller than the experimental value (3.55 eV in wurtzite GaN), and reported values for cubic GaN range from 3.25 to 3.5 eV (Davis 1991, Powell *et al* 1990).

3.2. Ordered $Ga_{1-x}Al_xN$ alloys

For the Ga_{0.75}Al_{0.25}N ordered alloy (x = 0.25), the calculations were performed for 58 k points in the irreducible part of the Brillouin zone to achieve self-consistency in the charge density. For Al, the valence states are Al(3s, 3p, 3d). The calculated dispersion curves are presented in figure 4. The point group symmetry at the N atom is C_{3v}. The dispersion curves are approximately similar to those of GaN as shown in figure 2 except the splitting of states because of the lower point group symmetry. The fundamental gap is direct and has a value of 2.46 eV. The other results are similar to those for Ga₄N₄.

The ordered structure $Ga_2Al_2N_4$ has a C_{2v} point group symmetry at N and the selfconsistent calculation has been performed for 98 selected k points. The dispersion curves for the $Ga_{0.50}Al_{0.50}N$ alloy are presented in figure 5. They are very similar to those of the



Figure 7. The dispersion curves for an Al_4N_4 super cell containing an eight-atom unit cell.



Figure 8. The variation of band gap (eV) with the concentration *x* in the random $Ga_{1-x}Al_xN$ alloys.

 $Ga_{0.75}Al_{0.25}N$ alloy except that the number of split bands increases further because of a lower point group symmetry. Here again, the order of the states at the Γ point is similar to those of the Ga_4N_4 ordered structure.

The dispersion curves for the ordered $Ga_{0.25}Al_{0.75}N$ alloy are shown in figure 6. The point group symmetry at the N atom is again $C_{3\nu}$ and the self-consistent calculations have

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been performed for 58 selected k points. Here, one finds that at the Γ point the lowest conduction state corresponds to the X_{1c}^{zb} symmetry of the Brillouin zone of the zinc-blende structure. The conduction state Γ_{1c}^{sc} of the super unit cell appears above the X_{1c}^{zb} state. This result is in contrast to those of the other structures containing smaller concentrations of AI atoms. The gap which appears to be direct here is, in fact, indirect and one may call it a pseudo-direct band gap. The indirect band gap has a magnitude of 3.28 eV as compared to the direct band gap of 3.66 eV. This reverse in the order of Γ_{1c}^{zb} and X_{1c}^{zb} in AlN originates from the fact that the Γ_{1c}^{zb} state is sensitive to the potential around the cation nucleus. For cation AI, the atomic number Z is smaller than that of Ga and, therefore, the potential is weaker and this leads the Γ_{1c}^{zb} state to appear above the X_{1c}^{zb} state. On the other hand, the X_{1c}^{zb} state is an antibonding mixed state of the s state of the anion and the p state of the cation. As the p-state wavefunctions vanish at the nucleus, they are less sensitive to Z. This results in the similarity of the X_{1c}^{zb} state in GaN and AlN.

3.3. Al₄N₄

The radius of the muffin tin sphere for each atom is 1.76 au. The computed dispersion curves along symmetry axes are shown in figure 7.

The order of states at the Γ point for Al₄N₄ in the neighbourhood of the fundamental energy gap is similar to that of the GaAl₃N₄ ordered structure, i.e. they are in the sequence Γ_{15v}^{sc} , X_{1c}^{zb} , and Γ_{1c}^{sc} towards the high-energy side. The band is indirect as is also seen in the two-atom unit cell of the zinc-blende structure of AlN. The density of states has been computed again for a mesh of 110 special k points in the irreducible part of the Brillouin zone with a Gaussian broadening of 0.005 Ryd. The total density of states is depicted in figure 3(e). In contrast to GaN, the states in the neighbourhood of the top of the valence band now originate from the hybridized Al(3p, 3d) and N(2p) states and their contributions are comparable. The ionic gap is now much larger. The states near the bottom of the valence band are comprised of the hybridized Al(3s, 3p, 3d) and N(2s) states. The indirect band gap is 3.23 eV in contrast to the direct one, which is 4.35 eV.

3.4. Random $Ga_{1-x}Al_xN$ alloys (x = 0.25, 0.50, 0.75)

3.4.1. Electronic density of states. For the $Ga_{1-x}Al_xN$ random alloy (x = 0.25), the total electronic density of states was obtained for 290 selected k points of the irreducible part of the Brillouin zone and is presented in figure 3(b). The main peaks appear near -14.5, -13.0, -11.2, -5.8, and -2.1 eV.

For the x = 0.50 random alloy, the total electronic density of states has been computed for 455 selected k points and the result is shown in figure 3(c). The low-lying peaks appear near -14.1, -12.8, -11.8, -5.1, and -1.4 eV. The major peaks are slightly shifted towards the higher-energy side with increasing x.

For the x = 0.75 random alloy, the total electronic density of states has been determined for 290 selected k points in the irreducible part of the Brillouin zone and is shown in figure 3(d). The main peaks in the valence band region are near -13.5, -12.6, -11.5, -5.2, and -1.6 eV. The density is comparatively high near the top of the valence band. We are not aware of any experimental data for the random alloys for comparison.

3.4.2. The energy gap. Equations (1) and (2) are utilized to determine the variation of the direct and indirect energy gaps for the various concentrations of the constituent atoms in the random $Ga_{1-x}Al_xN$ alloys. The calculated values are compared with the experimental points

Systems	Transition	Present work	Other calculations	Experiment
GaN	$\Gamma_{15v}-\Gamma_{1c}$	1.9 ^d	2.23 ^a , 2.0 ^b , 1.97 ^c , 2.01 ^e , 2.1 ^f , 2.08 ^g ,	$3.52^{j}, 3.2^{k}, 3.4^{l}, 3.3^{m}$
	Γ_{15v} – X_{1c}	3.28 ⁱ	2.32^{c} $3.36^{\text{a}}, 3.16^{\text{c}},$ 3.2^{f}	
Ga _{0.75} Al _{0.25} N	$\Gamma_{15v} - \Gamma_{1c}$	2.46 ^d	2.51°	4.05 ¹
Ga _{0.50} Al _{0.50} N	$\Gamma_{15v} - \mathbf{X}_{1c}$ $\Gamma_{12v} - \Gamma_{1c}$	3.29 ^r 3.01 ^d	3.35° 3.06°	4.9 ¹
Ga _{0.25} Al _{0.75} N	$\Gamma_{12v} - \Gamma_{12c}$ $\Gamma_{15v} - \Gamma_{1c}$	3.24 ¹ 3.66 ^d	3.45 ^c 3.67 ^c	5.6 ¹
AlN	Γ_{15v} -X _{1c} Γ_{15v} -X _{1c}	3.28 ⁱ 4.35 ^d	3.22 ^c 4.53 ^a , 4.25 ^c ,	6.1 ¹ , 6.28 ⁿ
	Γ_{15v} –X _{1c}	3.23 ⁱ	4.52 ^e , 4.2 ^f 3.40 ^a , 3.16 ^c ,	
AlN	$\Gamma_{15v} - X_{1c}$ $\Gamma_{15v} - X_{1c}$ $\Gamma_{15v} - X_{1c}$	3.28 ^d 3.23 ⁱ	3.22 ^c 4.53 ^a , 4.25 ^c , 4.52 ^e , 4.2 ^f 3.40 ^a , 3.16 ^c , 3.2 ^f	6.1 ¹ , 6.28 ⁿ

Table 2. The energy gap (eV) in the zinc-blende structure for the ordered $Ga_{1-x}Al_xN$ structures.

^a LMTO-ASA (Christensen and Gorczyca 1994).

^b FP-LMTO (Fiorentini et al 1993).

^c LMTO-ASA (Albanesi et al 1993).

^d Direct gap.

^e LMTO (Lambrecht and Segall 1994).

^f Norm conserving pseudopotential (Rubio et al 1993).

^g Norm conserving pseudopotential (Min et al 1992).

^h Pseudopotential (Jenkins et al 1994).

ⁱ Indirect gap.

^j Cathodoluminescence at 53 K on epitaxial films (Harrison 1985).

^k Optical absorption (Lei *et al* 1992).

¹ Optical absorption (Yoshida et al 1982).

^m Photoluminescence and cathodoluminescence (Paisley et al 1989, 1992).

ⁿ Optical absorption at 300 K in wurtzite structure (Perry and Rutz 1978).

in figure 8. One observed that the indirect gap shows little variation with the concentration. On the other hand, the direct gap shows a rapid variation, which is very much linear except a quite small bowing in the middle of the concentration range, but this small bowing is opposite to that observed by Yoshida *et al* (1982). It seems that the experimentally observed bowing may not arise from the disorder in the composition of atoms but from other types of disorder such as bond length relaxation as has been seen by Albanesi *et al* (1993).

From table 2, we observe that for the ordered systems $GaAl_3N_4$ and Al_4N_4 the gap is seen to be indirect. A perusal of figure 8 reveals a crossover from direct to indirect gap for the random $Ga_{1-x}Al_xN$ alloys at a concentration of x = 0.59 for which the energy gap $E_g = 3.26$ eV. These results are in agreement with those of Albanesi *et al* (1993) who have obtained a crossover at x = 0.57 and $E_g = 3.22$ eV.

4. Conclusions

The full-potential LMTO method is capable of predicting quite well the electronic properties of the alloys of the wide-band-gap semiconductors. A nearly linear variation with the concentration x in the ordered and random $Ga_{1-x}Al_xN$ configurations has been observed

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in the lattice constant and the direct energy band gap, respectively. On the other hand, the indirect energy band gap remains invariant. By employing a cation nearest-neighbour tetrahedron approximation in the cluster expansion method, we observe a direct to indirect gap crossover at x = 0.59. The band gap bowing is seen to be very small.

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References

Agrawal B K and Agrawal S 1994a Physica C 234 29 -1994b Physica C 233 8 -1995 Preprint Agrawal B K, Yadav P S and Agrawal S 1994 Phys. Rev. B 50 14881 Akasaki I and Amano H 1992 Wide Band Gap Semiconductors (MRS Symp. Proc. 242) ed T D Moustakas, J I Pankove and Y Hamakawa (Pittsburgh, PA: Materials Research Society) p 383 Albanesi E A, Lambrecht W R L and Segall B 1993 Phys. Rev. B 48 17 841 Amano H, Kito M and Hiramitsu K 1989 Japan. J. Appl. Phys. 28 L2112 Christensen N E and Gorczyca I 1994 Phys. Rev. B 50 4402 Connolly J W D and Williams A R 1983 Phys. Rev. B 27 5169 Davis R F 1991 Proc. IEEE 79 702 Fiorentini V, Methfessel M and Scheffler M 1993 Phys. Rev. B 47 13353 Gerlich D S, del Sole L and Slack G A 1986 J. Phys. Chem. Solids 47 437 Goodby R W, Schulter M and Sham L J 1986 Phys. Rev. Lett. 56 2415 Gorczyka I and Christensen N E 1991 Solid State Commun. 80 335 Harrison W A 1985 Phys. Rev. B 31 2121 Hedin L and Lundquist B I 1971 J. Phys. C: Solid State Phys. 4 2063 Jenkins S J, Srivastava G P and Inkson J C 1994 J. Phys. C: Solid State Phys. 6 8781 Lambrecht W R L and Segall B 1992 Wide Band Gap Semiconductors ed T D Moustakas, J I Pankove and Y Hamakawa MRS Symp. Proc. 242 (Pittsburgh, PA: Materials Research Society) p 367 -1994 unpublished Lei T and Moustakas T D 1992 Wide Band Gap Semiconductors ed T D Moustakas, J I Pankove and Y Hamakawa MRS Symp. Proc. 242 (Pittsburgh, PA: Materials Research Society) p 433 Lei T, Moustakas T D, Graham R J, He Y and Berkowitz S J 1992 J. Appl. Phys. 71 4933 and references therein Martin G, Strite S, Thronton J and Morkoc H 1991 Appl. Phys. Lett. 58 21 Methfessel M 1988 Phys. Rev. B 38 1537 Min B J, Chan C T and Ho K M 1992 Phys. Rev. B 45 1159 Miwa K and Fukumotoa A 1993 Phys. Rev. B 48 7897 Mizuta M, Fujieda S, Matsumoto Y and Kowamura T 1986 Japan. J. Appl. Phys. 25 L945 Molnar R J and Moustakas T D 1993 Bull. Am. Phys. Soc. 38 445 Muñoz A and Kunk K 1991 Phys. Rev. B 44 10 372 Nakamura S, Senoh M and Mukai T 1991 Japan. J. Appl. Phys. 30 L1708 Paisley M, Sitar Z, Posthill J B and Davis R F 1989 J. Vac. Sci. Technol. A 7 701 -1992 J. Mater. Sci. Lett. 11 261 Perdew J P and Levy M 1983 Phys. Rev. Lett. 51 1884 Perlin P, Carillon C J, Itie J P, San Miguel A I and Polian A 1992a Phys. Rev. B 45 83 Perlin P, Grzegory I, Teisseyre H and Suski T 1992b Phys. Rev. B 45 13 307 Perry B and Rutz R F 1978 Appl. Phys. Lett. 33 319 Powell R C et al 1990 Diamond, Boron Nitride, Silicon Carbide and Related Wide Bandgap Semiconductors ed T J Glass, R F Messier and N Fujimori MRS Symp. Proc. 162 (Pittsburgh, PA: Material Research Society) p 525 Rubio A and Cohen M L 1995 Phys. Rev. B 51 4343 Rubio A, Corkill J L, Cohen M L, Shirley E L and Louie S G 1993 Phys. Rev. B 48 11 810

- Sanchez J M and de Fontaine D 1981 Structure and Bonding in Crystals vol 2, ed M O'Keefe and A Navrotsky (New York: Academic) p 117
- Sanchez J M, Ducastell F and Gratias D 1984 Physica A 128 334
- Schrwin M E and Drummond T J 1991 J. Appl. Phys. 69 8423
- Sham L J and Schulter M 1983 Phys. Rev. Lett. 51 1888
- Srivastava G P, Martins J L and Zunger A 1985 Phys. Rev. B 31 2561
- Strite S, Ruan J, Li Z, Salvador A, Chen H, Smith D J, Choyke W J and Morkoc H 1991 J. Vac. Sci. Technol. B 9 192
- Ueno M, Yoshida M, Onodera A, Shimomura O and Takemura K 1994 Phys. Rev. B 41 14
- Van der Walle G 1993 Wide Band Gap Semiconductors, Proc. 7th Semicond. Symp. (Trieste, 1993) (Amsterdam: North-Holland) Physica B 185 1–607
- Wettling W and Windschif J 1984 Solid State Commun. 50 33
- Wyckoff R W 1964 Crystal Structures 2nd edn, vol 1 (New York: Wiley-Interscience)
- Xia H, Xia Q and Ruof A L 1993 Phys. Rev. B 47 12 925
- Yeh C Y, Lu Z W, Froyen S and Zunger A 1992 Phys. Rev. B 46 10086
- Yoshida S, Misawa S and Gonda S 1982 J. Appl. Phys. 53 6844